

Search Notes

Application/Control No.

10/617,655

Examiner

Thien F. Tran

Applicant(s)/Patent under
Reexamination

KACHI ET AL.

Art Unit

2811

SEARCHED

Class	Subclass	Date	Examiner
257	13 79-84 97-99	4/12/2006	TT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Interference search history printout	4/12/2006	TT